

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	278	(WHITE near JERRY or LEE near RUSSELL)". inv. "	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 15:48
L2	278	(WHITE near JERRY or LEE near RUSSELL)". inv." and fluorescen\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 15:48
L3	278	(WHITE near JERRY or LEE near RUSSELL)". inv." and fluorescen\$3 and dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 15:48
L4	1	((WHITE near JERRY) (LEE near RUSSELL)). inv. and fluorescen\$3 and dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 15:50
L5	7	((WHITE near JERRY) (LEE near RUSSELL)). inv. and fluorescen\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 15:50
L6	1	(preparing and sample and semiconductor and device and inspection and encapsulation and material containing and dye and prepared and failure and area and wicked and sectioning and facilitate viewing and cross and section and dark and analysis and illumination).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 15:53

S1	10	("5592571" "5715334" "6324298" "6337472" "20020125136").pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 12:59
S2	360	(dye fluorescence ink) with (bright dark illumination) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/16 15:11
S3	9	(dye fluorescence ink) near2 (bright dark illumination) near2 (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:58
S4	4	(dye fluorescence ink) with (bright dark illumination) with (semiconductor chip electronic) with (defect failure)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:44
S5	27	382/145.ccls. and (ink fluorescence ink)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 13:25
S6	28	382/145.ccls. and (ink fluorescence dye)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:20
S7	769	382/145.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:20
S8	81	(dye fluorescence ink) same (bright dark illumination) same (semiconductor chip electronic) same (defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:57

S9	26098	(fluorescence) same (ink dye)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:58
S10	16271	(fluorescence) with (ink dye)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:58
S11	0	fluorescence near2 (dye ink) near2 (bright dark illumination) near2 (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 14:59
S12	30	fluorescence with (dye ink) with (bright dark illumination) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:03
S13	472	(bright dark illumination fluorescence) with (dye ink) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:00
S14	291	fluorescence with (dye ink) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:01
S15	4	fluorescence with (dye ink) with (semiconductor chip electronic) with (defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:02
S16	291	fluorescence with (dye ink) with (semiconductor chip electronic)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:05

S17	5	fluorescence with (dye ink) with (semiconductor chip electronic) with (inspection defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:05
S18	10	("5592571" "5715334" "6324298" "6337472" "20020125136").pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:09
S19	4	fluorescence with (dye ink) with (semiconductor chip electronic) with (defect failure delamination)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:10
S20	16	fluorescence near2 (dye ink) and (semiconductor chip electronic) near2 (defect failure delamination inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:14
S21	4	"3557015".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:14
S22	5	("3557015").URPN.	USPAT	OR	ON	2006/10/10 15:17
S23	311	382/144.ccls.	USPAT	OR	ON	2006/10/10 15:17
S24	2	382/144.ccls. and (dye ink)	USPAT	OR	ON	2006/10/10 15:17
S25	5	382/144.ccls. and (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:38
S26	6499	(crack near2 detect\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:29

S27	50	(crack near2 detect\$4) and (semiconductor chip) near2 (inspect\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 19:50
S28	3	(crack near2 detect\$4) and (semiconductor chip) near2 (inspect\$4) and (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:53
S29	198	382/141-153.ccls. and (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:46
S30	20	382/141-153.ccls. and fluorescence with (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:49
S31	7	382/141-152.ccls. and fluorescence with (dye ink)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:49
S32	1	(crack near2 detect\$4) and (semiconductor chip) with (inspect\$4) with (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:56
S33	850	438/15.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:57
S34	67	438/15.ccls. and (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:57

S35	51	438/15.ccls. and (ink dye) and (crack failure defect\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 15:59
S36	0	438/15.ccls. and (ink dye) with fluorescence	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 16:00
S37	1	438/15.ccls. and (ink dye) with fluorescen\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 16:05
S38	1	438/15.ccls. and (ink dye) same fluorescen\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 16:05
S39	2	438/15.ccls. and (ink dye) and fluorescen\$3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 16:06
S40	2	"5570431".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 16:06
S41	11	("3791198" "4483615" "4506980" "4650326" "4931949" "5004339" "5125741").PN. OR ("5570431").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/10 16:07
S42	67	(crack near2 detection) and (ink dye) near2 fluorescen\$2	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/10 16:08
S43	3990	382/141-152.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 19:50

S44	133	382/141-152.ccls. and (ultrasound acoustic)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 19:53
S45	3	"4218922".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/10 19:53
S46	65	fluorescen\$2 with (crack) with (detection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/11 15:54
S47	12	fluorescen\$2 near (crack) near (detection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/11 15:54
S48	2	airplane with bolt with dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 16:36
S49	86	airplane near2 bolt	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 19:40
S50	44	airplane near bolt	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 16:36
S51	0	airplane near2 bolt and dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 16:36

S52	0	airplane near2 bolt and ink	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 16:36
S53	2	encapsulat\$4 with dye with (crack failure defect) with wick\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 19:43
S54	0	250/201.03.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 19:43
S55	400	250/201.3.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 19:44
S56	63	250/201.3.ccls. and (defect failure)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 19:59
S57	0	250/201.3.ccls. and (ink dye) with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 20:00
S58	3211	(ink dye) with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 20:00
S59	589	(ink dye) near2 inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 20:00

S60	0	(ink dye) near2 inspection near encapsulat\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 20:01
S61	0	(ink dye) near2 inspection with encapsulat\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 20:02
S62	2	"20040125992".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/13 20:02
S64	91	airplane and bolt and dye	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 12:19
S65	20	airplane and bolt and dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 15:51
S66	118060	airplane dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 12:29
S67	257	airplane and dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 12:29
S68	6	airplane and dye near2 inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 12:34

S69	20	airplane and dye with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 13:42
S70	114	aircraft and dye with inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 13:42
S71	99	aircraft and dye with inspection not S69	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 14:40
S72	3991	382/141-152.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 14:40
S73	2	382/141-152.ccls. and (dye near2 inspect\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 14:41
S74	21802	dye and inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 15:51
S75	303	dye near2 inspection	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 15:51
S76	1	(semiconductor electronic) with (dye near2 inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 16:09

S77	0	(wick\$4) with (dye near2 inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 16:09
S78	35	(wick\$4) and (dye near2 inspection)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/15 16:09
S79	38	382/141-152.ccls. and (dark near illuminat\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/16 15:13
S81	38	382/141-152.ccls. and (dark near illuminat\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/16 23:15
S82	2	"6342400".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/16 23:15
S83	4	("4230754" "5651493" "6117352" "6117695").PN. OR ("6342400").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 01:00
S84	4	(Xanthane Naphthalimide Perylene Courmarin Fluorescein) and (dye near inspection)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 02:21
S85	851	438/15.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 02:21
S86	0	438/15.ccls. and (grind \$4 and polish\$4) with (cross near section)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 02:22
S87	38	438/15.ccls. and (grind \$4 and polish\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:50
S88	445	438/15.ccls. and (cross near section\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:49
S89	4	438/15.ccls. and (cross near sectioning)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:11

S90	36	dye near inspection and (cross near section\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 05:04
S91	0	dye near inspection and (grind\$4 and polish\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/10/17 03:50
S92	28	382/145.ccls. and (ink fluorescence ink)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/03 16:23
S93	199	382/141-152.ccls. and (ink fluorescence ink)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/03 16:23
S94	53	348/87-95.ccls. and (ink fluorescence ink)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/03 16:23
S95	71	438/15.ccls. and (ink dye)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/03 16:25
S96	70	250/201.3.ccls. and (defect failure)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/03 16:45

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